Application/Control No. Applicant(s)/Patent Under Reexamination 10/603,720 Notice of References Cited FUKUDA ET AL. Examiner Art Unit Page 1 of 1 Kiet T. Nguyen 2881 **U.S. PATENT DOCUMENTS Document Number** Date Country Code-Number-Kind Code MM-YYYY Name Classification US-6,538,254 03-2003 Tomimatsu et al. 250/442,11 В US-6,717,156 04-2004 Sugaya et al. 250/440.11 US-C 20 US-D US-Ε US-E G US-US-US-US-J. US-Κ US-US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Code-Number-Kind Code Country MM-YYYY Name , Classification Ν 0 Р Q R s **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) Ü

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